

THERMAL ANALYSIS

Thermal diffusivity and conductivity analyser

NETZSCH LFA 447 NanoFlash

The NETZSCH LFA 447 NanoFlash is used to measure thermal diffusivity and thermal conductivity on a variety of materials, such as ceramics, metals, composites, and multilayer systems.

The advantages of this technology are the variety of materials that can be analysed, the easy preparation of samples, the testing speed and the high accuracy of the results.

This instrument can determine abovementioned properties at room temperature and their evolution up to 300°C, due to embedded heating system.

The NETZSCH LFA 447 NanoFlash is based on laser flash technology. During a measurement, the lower surface of a sample with planar and parallel faces is initially heated by laser pulse with known energy and duration (flash) The change in temperature resulting on the upper face of the sample is then measured by an infra-red detector.

From the recorded temperature-time curve, which describes the thermal evolution of the sample, characteristic time intervals are calculated to determine the thermal diffusivity.

The thermal conductivity of the material to be analysed can be determined if its specific heat capacity and density are known.

Applications

- Measure of thermal properties in function of temperature
- Change of thermal properties in function of reaction time
- Evaluation of thermal barrier effect of a material or coating
- Evaluation of thermal conductivity ability of a material or coating



Specifications

- Temperature range RT to 300°C
- Thermal diffusivity range 0.01 mm²/s to 1000 mm²/s
- Thermal conductivity range 0.1 W/(m·K) to 2000 W/(m·K)
- Repeatibility Thermal diffusivity: ± 2%

Specific heat: ± 3%

Accuracy

Thermal diffusivity: \pm 36% Specific heat: \pm 5%

Flash source

Xenon Flash Lamp, wavelength: 150nm to 2000 nm Pulse Energy: up to ≈10 Joules

Sensor type

IR detector (InSb) with integrated dewar for LN2 cooling

Samples

Standard sample size: disk up to 25.4 mm diameter, or 6 mm / 8 mm / 10 mm / 12.7 mm square, up to 3 mm thick.

In addition, several sample holders are available to characterize different material forms:

- Bulk material
- Thin sheet for in-plane measurements
- Liquid with low viscosity
- Multilayers samples
- Powder

